

## SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic X-package with source and substrate interconnected, intended for v.h.f. applications, such as v.h.f. television tuners, f.m. tuners and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

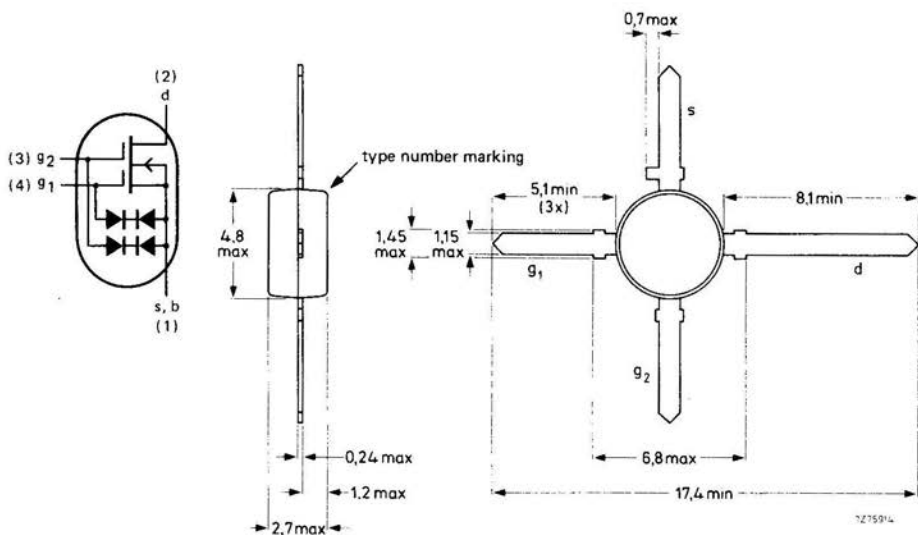
## QUICK REFERENCE DATA

Drain-source voltage	$V_{DS}$	max.	20 V	
Drain current	$I_D$	max.	20 mA	
Total power dissipation up to $T_{amb} = 75\text{ }^\circ\text{C}$	$P_{tot}$	max.	225 mW	
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$	
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 10\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	14 mS	←
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 10\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$	$C_{rs}$	typ.	20 fF	
Noise figure at optimum source admittance $I_D = 10\text{ mA}$ ; $V_{DS} = 10\text{ V}$ ; $+V_{G2-S} = 4\text{ V}$ ; $f = 200\text{ MHz}$	F	typ.	0,7 dB	

## MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-103.



## RATINGS

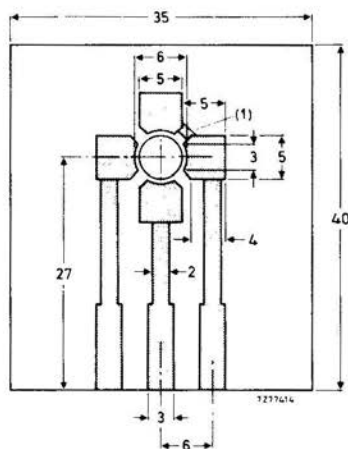
Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	$V_{DS}$	max.	20 V
Drain current (d.c. or average)	$I_D$	max.	20 mA
Drain current (peak value)	$I_{DM}$	max.	30 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 75\text{ }^\circ\text{C}$	$P_{tot}$	max.	225 mW
Storage temperature	$T_{stg}$	-65 to +150	$^\circ\text{C}$
Junction temperature	$T_j$	max.	150 $^\circ\text{C}$

## THERMAL RESISTANCE

From junction to ambient in free air  
mounted on the printed-circuit board (see Fig. 2)

$$R_{th\ j-a} = 335\text{ K/W}$$



Dimensions in mm

(1) Connection made by a strip or Cu wire.

Fig. 2 Single-sided 35  $\mu\text{m}$  Cu-clad epoxy fibre-glass printed-circuit board, thickness 1,5 mm. Tracks are fully tin-lead plated. Board in horizontal position for  $R_{th}$  measurement.

## STATIC CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

Gate cut-off currents

$$\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$$

$$\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$$

$$\pm I_{G1-SS} < 50\text{ nA}$$

$$\pm I_{G2-SS} < 50\text{ nA}$$

Gate-source breakdown voltages

$$\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$$

$$\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$$

$$\pm V_{(BR)G1-SS} > 6\text{ V}$$

$$\pm V_{(BR)G2-SS} > 6\text{ V}$$

Drain current

$$V_{DS} = 10\text{ V}; V_{G1-S} = 0; +V_{G2-S} = 4\text{ V}; T_j = 25\text{ }^{\circ}\text{C}$$

$$I_{DSS} \quad 4\text{ to }25\text{ mA}$$

Gate-source cut-off voltages

$$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$$

$$I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$$

$$-V_{(P)G1-S} < 2,5\text{ V}$$

$$-V_{(P)G2-S} < 2,5\text{ V}$$

## DYNAMIC CHARACTERISTICS

Measuring conditions (common source):  $I_D = 10\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Transfer admittance at  $f = 1\text{ kHz}$

$$|Y_{fs}| \quad \begin{array}{l} > 10\text{ mS} \\ \text{typ. } 14\text{ mS} \end{array}$$

Input capacitance at gate 1;  $f = 1\text{ MHz}$

$$C_{ig1-s} \quad \text{typ. } 2,1\text{ pF}$$

Input capacitance at gate 2;  $f = 1\text{ MHz}$

$$C_{ig2-s} \quad \text{typ. } 1,0\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$C_{rs} \quad \text{typ. } 20\text{ fF}$$

Output capacitance at  $f = 1\text{ MHz}$

$$C_{os} \quad \text{typ. } 1,1\text{ pF}$$

Noise figure at  $f = 100\text{ MHz}; G_S = 1\text{ mS}$

$$F \quad \begin{array}{l} \text{typ. } 0,7\text{ dB} \\ < 1,7\text{ dB} \end{array}$$

Noise figure at  $f = 200\text{ MHz}; G_S = 2\text{ mS}$

$$F \quad \begin{array}{l} \text{typ. } 1,0\text{ dB} \\ < 2,0\text{ dB} \end{array}$$

Transducer gain at  $f = 100\text{ MHz}; G_S = 1\text{ mS}; G_L = 0,5\text{ mS}$

$$G_{tr} \quad \text{typ. } 29\text{ dB}$$

Transducer gain at  $f = 200\text{ MHz}; G_S = 2\text{ mS}; G_L = 0,5\text{ mS}$

$$G_{tr} \quad \text{typ. } 26\text{ dB}$$

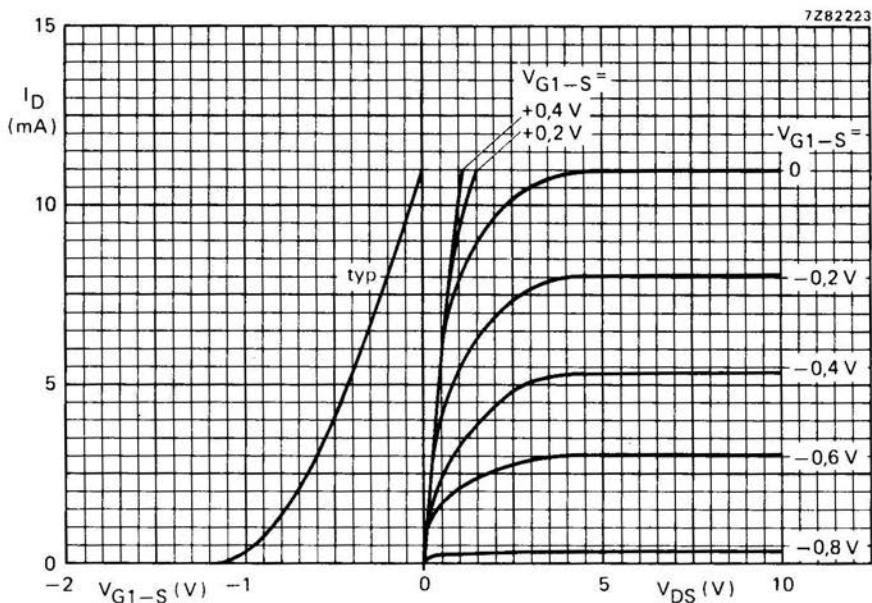


Fig. 3 Left-hand graph:  $V_{DS} = 10\text{ V}$ ;  $V_{G2-S} = +4\text{ V}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ . Right-hand graph:  $V_{G2-S} = +4\text{ V}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .

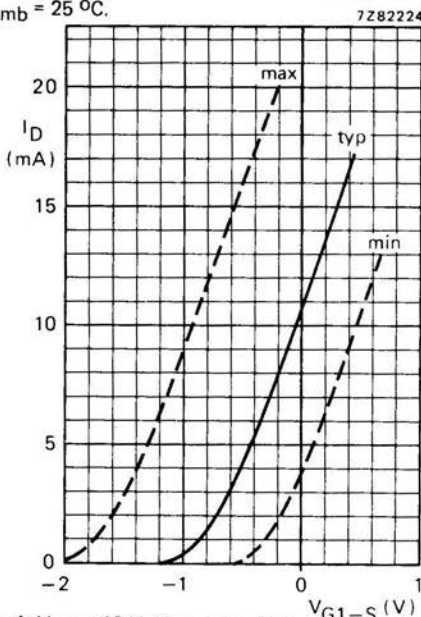


Fig. 4  $V_{DS} = 10\text{ V}$ ;  $V_{G2-S} = +4\text{ V}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .

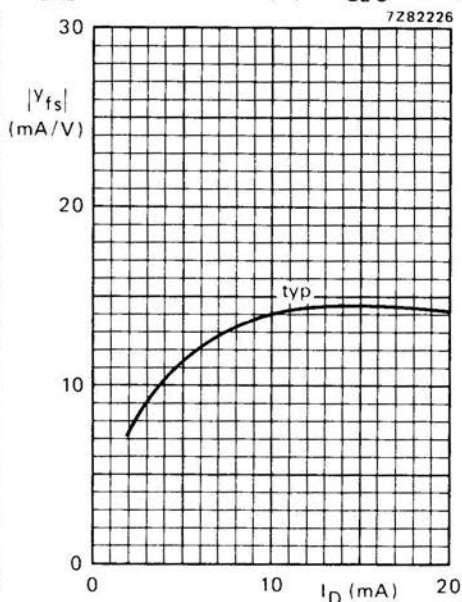


Fig. 5  $V_{DS} = 10\text{ V}$ ;  $V_{G2-S} = +4\text{ V}$ ;  $f = 1\text{ kHz}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .

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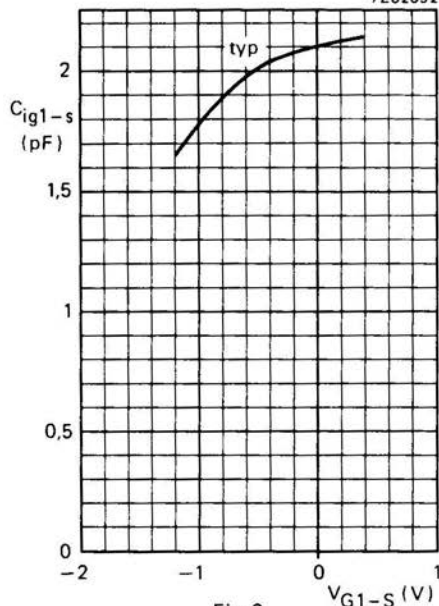


Fig. 6.

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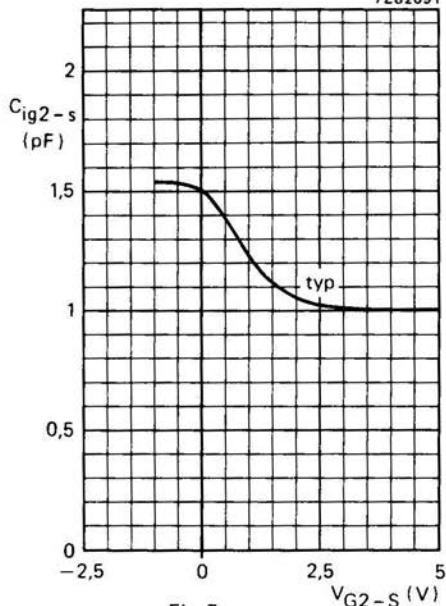


Fig. 7.

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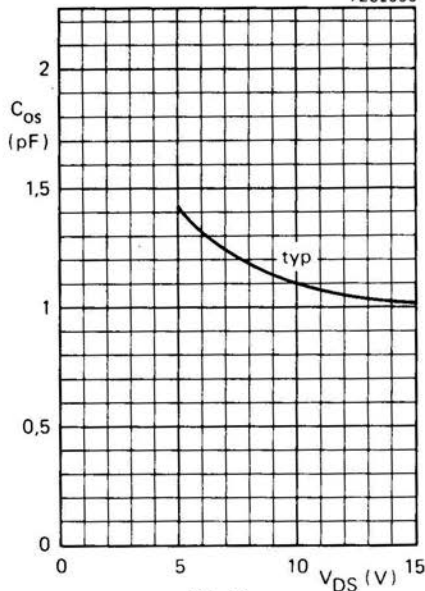


Fig. 8.

Measuring conditions:

Fig. 6  $V_{DS} = 10$  V;  $V_{G2-S} = +4$  V;  $f = 1$  MHz;  
 $T_{amb} = 25$  °C.

Fig. 7  $V_{DS} = 10$  V;  $V_{G1-S} = 0$ ;  $f = 1$  MHz;  
 $T_{amb} = 25$  °C.

Fig. 8  $V_{G2-S} = +4$  V;  $I_D = 10$  mA;  $f = 1$  MHz;  
 $T_{amb} = 25$  °C.

Measuring conditions for Figs 9 to 12:  $V_{DS} = 10 \text{ V}$ ;  $I_D = 10 \text{ mA}$ ;  $V_{G2-S} = +4 \text{ V}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

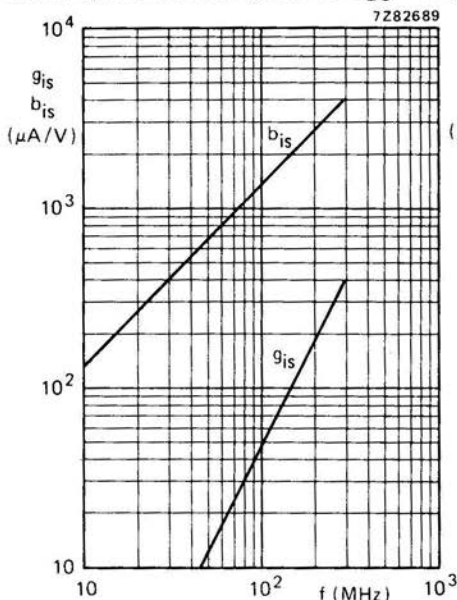


Fig. 9.

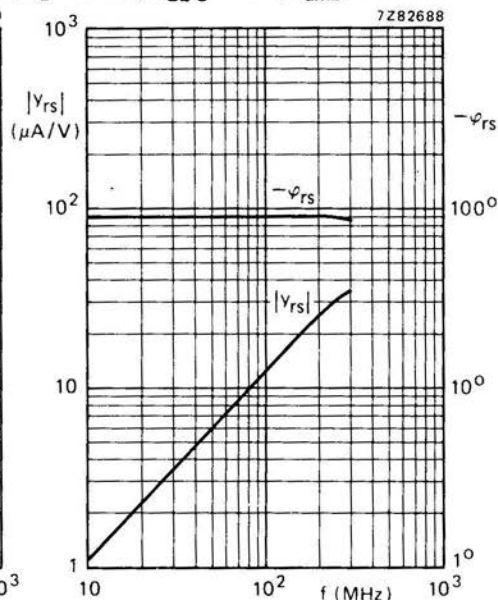


Fig. 10.

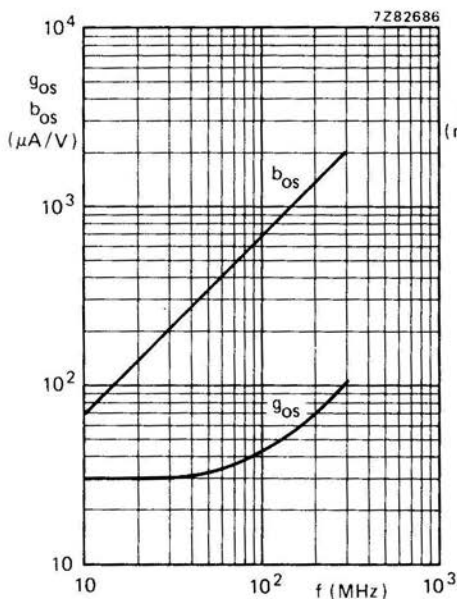


Fig. 11.

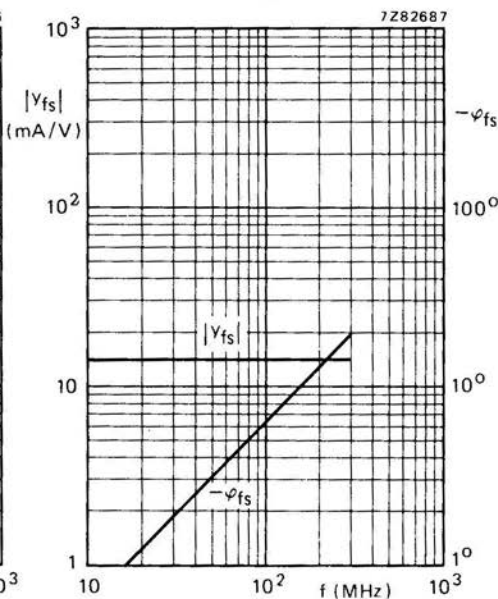


Fig. 12.

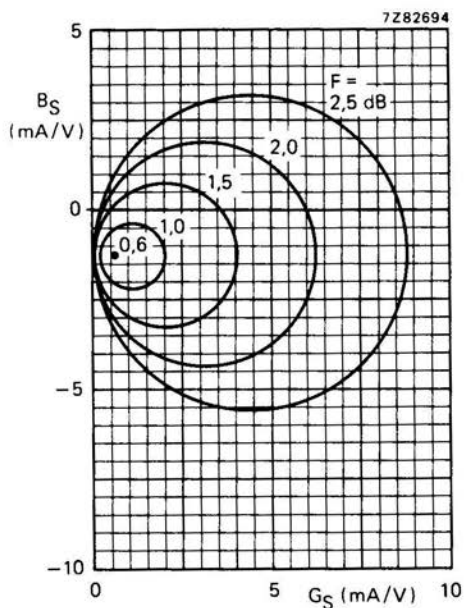


Fig. 13  $V_{DS} = 10$  V;  $V_{G2-S} = +4$  V;  $I_D = 10$  mA;  
 $f = 100$  MHz;  $T_{amb} = 25$  °C; circles of typical  
 constant noise figures.

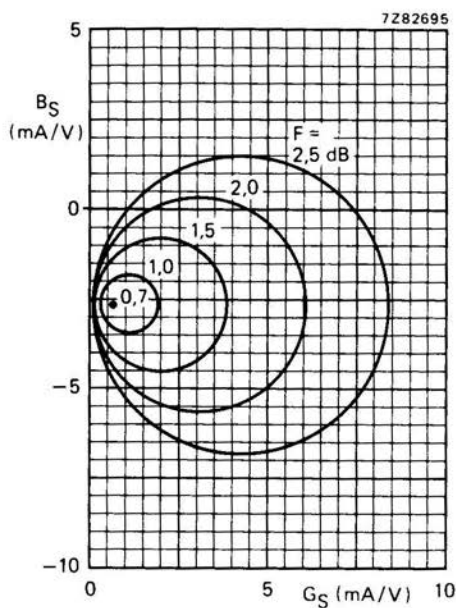


Fig. 14  $V_{DS} = 10$  V;  $V_{G2-S} = +4$  V;  $I_D = 10$  mA;  
 $f = 200$  MHz;  $T_{amb} = 25$  °C; circles of typical  
 constant noise figures.

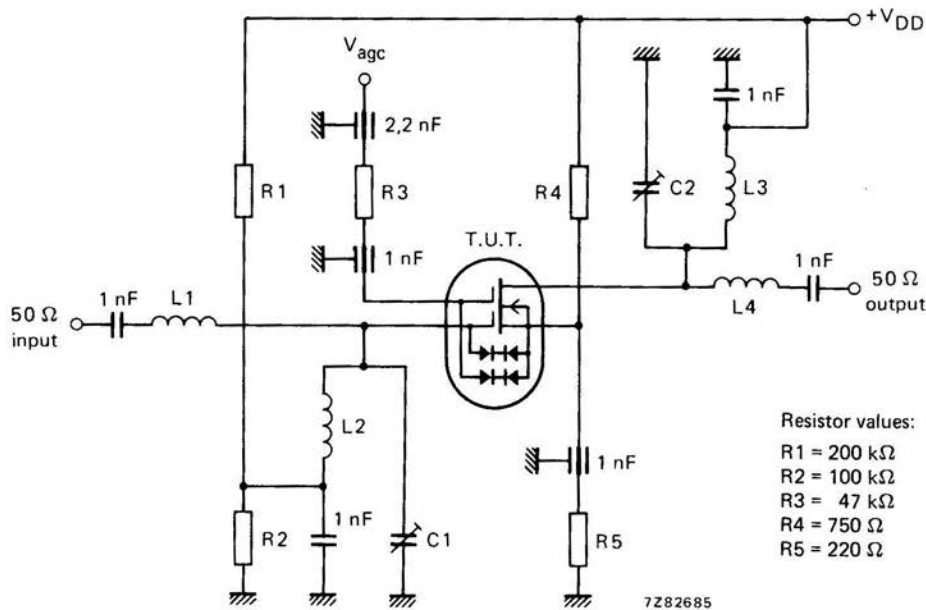


Fig. 15 Automatic gain control test circuit at  $f = 200$  MHz (see also Fig. 16).  
 $V_{DD} = 16$  V;  $G_S = 2$  mA/V;  $G_L = 0,5$  mA/V.

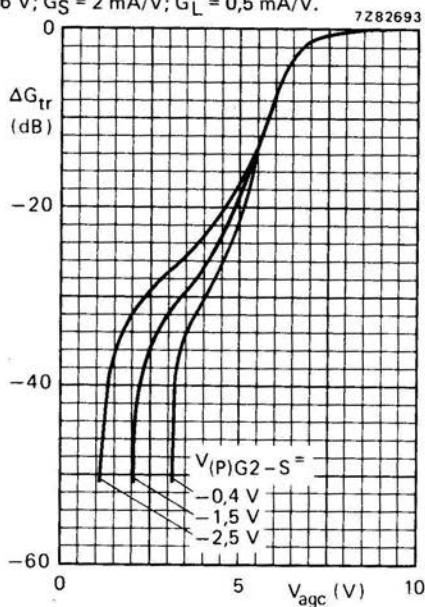


Fig. 16  $V_{DD} = 16$  V;  $f = 200$  MHz;  
 $T_{amb} = 25$   $^{\circ}$ C; typical values;  
 see also Fig. 15.